

<b>Notice of References Cited</b>	Application/Control No. 10/040,173	Applicant(s)/Patent Under Reexamination VAIDYANATHAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,618,996	10-1986	Rafal et al.	455/46
	B	US-6,148,020	11-2000	Emi, Tetsuichi	375/132
	C	US-6,411,644	06-2002	Myer, Robert Evan	375/132
	D	US-6,654,429	11-2003	Li, Ye	375/316
	E	US-6,853,689	02-2005	Nilsson, Johan	375/267
	F	US-6,912,258	06-2005	Birru, Dagnachew	375/340
	G	US-2002/0044524	04-2002	Laroia et al.	370/203
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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